Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/849,221	INUKAI ET AL.	
Examiner	Art Unit	
Caridad M. Everhart	2891	

SEARCHED					
Class	Subclass	Date	Examiner		
438	694	4/20/2005	СМЕ		
438	725	4/20/2005	СМЕ		
438	953	4/20/2005	СМЕ		
438	948	4/20/2005	СМЕ		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST(attached)	4/20/2005	СМЕ		
EAST:((hydrogen or "h.sub.2") same photoresist same (inert or ar or argon or he or helium))	4/20/2005	CME		